

Notice of References Cited	Application/Control No. 10/573,823		Applicant(s)/Patent Under Reexamination ITO, YASUSHI	
	Examiner Hai H. Huynh		Art Unit 3747	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-4,003,345	01-1977	Bradley, Curtis E.	123/3
*	B	US-4,103,653	08-1978	Ueno et al.	123/406.11
*	C	US-5,293,857 A	03-1994	Meyer, Stanley	123/568.18
*	D	US-5,611,307 A	03-1997	Watson, Harry C.	123/254
*	E	US-7,013,845 B1	03-2006	McFarland et al.	123/3
*	F	US-7,174,861 B2	02-2007	Allston et al.	123/1A
*	G	US-2005/0229872 A1	10-2005	Lange, David	123/003
*	H	US-2004/0261762 A1	12-2004	Sloane et al.	123/304
*	T	US-2006/0101823 A1	05-2006	Takemoto et al.	060/716
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	WO 2006/126341	11-2006		Kuroki et al	F02M-25/12
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.